

Characteristics of broadband InP millimeter-wave amplifiers for radiometry

E.J. Wollack and M.W. Pospieszalski. "Characteristics of broadband InP millimeter-wave amplifiers for radiometry." 1998 MTT-S International Microwave Symposium Digest 98.2 (1998 Vol. II [MWSYM]): 669-672.

The performance of InP HEMT (High-Electron Mobility Transistor) amplifiers is characterized in a direct detection 3.8 mm receiver over a temperature range of 50 to 300 K. The effects of low frequency noise up-conversion are observed in the total power response. The measured spectrum of gain fluctuations at room temperature is characterized by $\frac{1}{f} \frac{\Delta G}{G} \propto \frac{1}{f^{\alpha}}$, with an index $\alpha \approx 0.9$ and $\frac{\Delta G}{G} \propto f^{-1/6}$ per device used in the amplification chain. When the devices are cooled to 50 K, $\frac{\Delta G}{G}$ increases by a factor of 5. The measured receiver sensitivity is 3 mK $\text{Hz}^{-1/2}$ at an ambient temperature of 300 K and 0.8 mK $\text{Hz}^{-1/2}$ at 50 K. The measured sensitivity at room temperature is the best reported for a HEMT direct detection receiver in the 3 mm atmospheric window. At 50 K the observed receiver sensitivity is competitive with the performance of sub-Kelvin bolometric detectors or SIS junctions used for direct detection.

 [Return to main document.](#)